January 2006

FDS8690 N-Channel PowerTrench[®] MOSFET

FAIRCHILD

SEMICONDUCTOR®

FDS8690 N-Channel PowerTrench[®] MOSFET

30V, 14A, 7.6mΩ

General Description

This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge, low $r_{DS(on)}$ and fast switching speed.

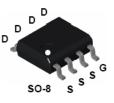
Applications

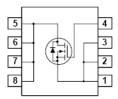
- Notebook CPU power supply
- Synchronous rectifier

Features

- Max r_{DS(on)} = 7.6mΩ, V_{GS} = 10V, I_D = 14A
- Max r_{DS(on)} = 11.4mΩ, V_{GS} = 4.5V, I_D = 11.5A
- High performance trench technology for extremely low r_{DS(on)} and fast switching
- Very low gate charge
- High power and current handling capability
- 100% R_G tested
- RoHS Compliant







Absolute Maximum Ratings T_A = 25°C unless otherwise Noted

Symbol	Parameter		Ratings	Units	
V _{DS}	Drain to Source Voltage		30	V	
V _{GS}	Gate to Source Voltage		±20	V	
	Drain Current -Continuous	(Note 1a)	14	•	
D	-Pulsed		100	— A	
E _{AS}	Single Pulse Avalanche Energy	(Note 3)	210	mJ	
P _D	Power Dissipation for Single Operation	(Note 1a)	2.5		
		(Note 1b)	1.2	W	
		(Note 1c)	1.0		
T _J , T _{STG}	Operating and Storage Temperature		-55 to +150	°C	

Thermal Characteristics

R_{\thetaJA}	Thermal Resistance, Junction to Ambient	(Note 1a)	50	°C/W
$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case	(Note 1)	25	°C/W

Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape Width	Quantity
FDS8690	FDS8690	13"	12mm	2500 units

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	cteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	I _D = 250μA, V _{GS} = 0V	30			V
∆B _{VDSS}	Breakdown Voltage Temperature	$I_D = 250 \mu A$, referenced to		34.3		mV/°C
ΔTJ		25°C				
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 24V, V_{GS} = 0V$			1	μA
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$			±100	nA
On Chara	cteristics (Note 2)					
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	1	1.6	3	V
$\Delta V_{GS(th)} \Delta T_J$	Gate to Source Threshold Voltage Temperature Coefficient	I _D =250μA, referenced to 25°C		- 4.5		mV/°C
		V _{GS} = 10V, I _D = 14A		6.3	7.6	
r DOVONIN	Drain to Source On Resistance	V _{GS} = 4.5V, I _D = 11.5A		8.6	11.4	mΩ
rds(ON)		V _{GS} = 10V, I _D = 14A, T _J = 125°C		9.0	10.9	11132
Dynamic	Characteristics					
Ciss	Input Capacitance			1260	1680	pF
C _{oss}	Output Capacitance	$V_{DS} = 15V, V_{GS} = 0V,$ f = 1MHz		535	715	pF
	Develope Transfer Conseilence	1 - 111112				
C _{rss}	Reverse Transfer Capacitance			80	120	pF
C _{rss} R _G	Gate Resistance	f = 1MHz		80 1.1	120	pF Ω
R _G	Gate Resistance	f = 1MHz			120	· ·
R _G Switchinç					120	· ·
R _G Switching t _{d(on)}	Gate Resistance Characteristics (Note 2)	f = 1MHz V _{DS} = 15V, I _D = 1A, V _{GS} = 10V, R _{GS} = 6Ω		1.1		Ω
R _G Switching t _{d(on)} t _r	Gate Resistance Characteristics (Note 2) Turn-On Delay Time	V _{DS} = 15V, I _D = 1A,		1.1 8.0	16	Ω ns
R _G Switching t _{d(on)} t _r t _{d(off)}	Gate Resistance y Characteristics (Note 2) Turn-On Delay Time Rise Time	V _{DS} = 15V, I _D = 1A,		1.1 8.0 1.8	16 10	Ω ns ns
R _G Switching t _{d(on)} t _r t _{d(off)} t _f	Gate Resistance Characteristics (Note 2) Turn-On Delay Time Rise Time Turn-Off Delay Time	V _{DS} = 15V, I _D = 1A,		1.1 8.0 1.8 26	16 10 42	Ω ns ns
R _G Switching t _{d(on)} t _r t _{d(off)} t _f Q _g	Gate Resistance Characteristics (Note 2) Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time	$V_{DS} = 15V, I_{D} = 1A, V_{GS} = 10V, R_{GS} = 6\Omega$ $V_{DS} = 15V, V_{GS} = 10V$		1.1 8.0 1.8 26 19	16 10 42 35	Ω ns ns ns ns
R _G Switching t _{d(on)} t _r t _{d(off)} t _f Q _g Q _g	Gate Resistance g Characteristics (Note 2) Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge	$V_{DS} = 15V, I_{D} = 1A,$ $V_{GS} = 10V, R_{GS} = 6\Omega$ $V_{DS} = 15V, V_{GS} = 10V$ $I_{D} = 14A$		1.1 8.0 1.8 26 19 18.8	16 10 42 35 27	ns ns ns ns nc
R _G	Gate Resistance Characteristics (Note 2) Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge Total Gate Charge	$V_{DS} = 15V, I_{D} = 1A, V_{GS} = 10V, R_{GS} = 6\Omega$ $V_{DS} = 15V, V_{GS} = 10V I_{D} = 14A$ $V_{DS} = 15V, V_{GS} = 5V$		1.1 8.0 1.8 26 19 18.8 10	16 10 42 35 27	Ω ns ns ns nC nC
R _G Switching t _{d(on)} t _r t _{d(off)} t _f Q _g Q _g Q _{gs} Q _{gd}	Gate Resistance g Characteristics (Note 2) Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge Gate to Source Gate Charge	$V_{DS} = 15V, I_{D} = 1A, V_{GS} = 10V, R_{GS} = 6\Omega$ $V_{DS} = 15V, V_{GS} = 10V I_{D} = 14A$ $V_{DS} = 15V, V_{GS} = 5V$		1.1 8.0 1.8 26 19 18.8 10 3.5	16 10 42 35 27	Ω ns ns ns nC nC
R _G Switching t _{d(on)} t _r t _{d(off)} t _f Q _g Q _g Q _{gs} Q _{gd} Drain-Sou	Gate ResistanceCharacteristics (Note 2)Turn-On Delay TimeRise TimeTurn-Off Delay TimeFall TimeTotal Gate ChargeTotal Gate ChargeGate to Source Gate ChargeGate to Drain Charge	$V_{DS} = 15V, I_{D} = 1A,$ $V_{GS} = 10V, R_{GS} = 6\Omega$ $V_{DS} = 15V, V_{GS} = 10V$ $I_{D} = 14A$ $V_{DS} = 15V, V_{GS} = 5V$ $I_{D} = 14A$		1.1 8.0 1.8 26 19 18.8 10 3.5	16 10 42 35 27	Ω ns ns ns nC nC
R _G Switching t _{d(on)} t _r t _{d(off)} t _f Q _g Q _g Q _{gs} Q _{gd}	Gate Resistance g Characteristics (Note 2) Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge Gate to Source Gate Charge Gate to Drain Charge urce Diode Characteristics	$V_{DS} = 15V, I_{D} = 1A,$ $V_{GS} = 10V, R_{GS} = 6\Omega$ $V_{DS} = 15V, V_{GS} = 10V$ $I_{D} = 14A$ $V_{DS} = 15V, V_{GS} = 5V$ $I_{D} = 14A$		1.1 8.0 1.8 26 19 18.8 10 3.5 2.9	16 10 42 35 27 14	Ω ns ns ns nC nC nC

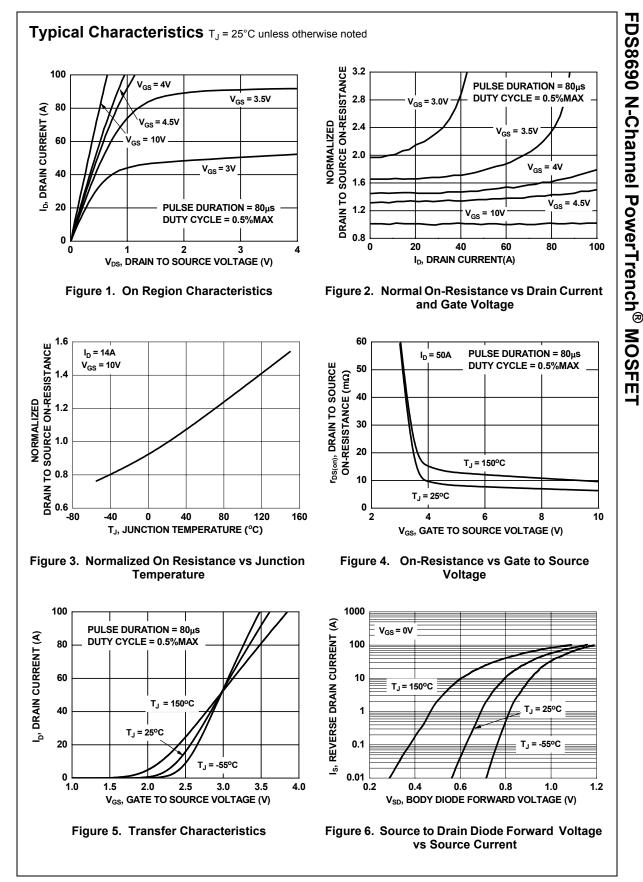


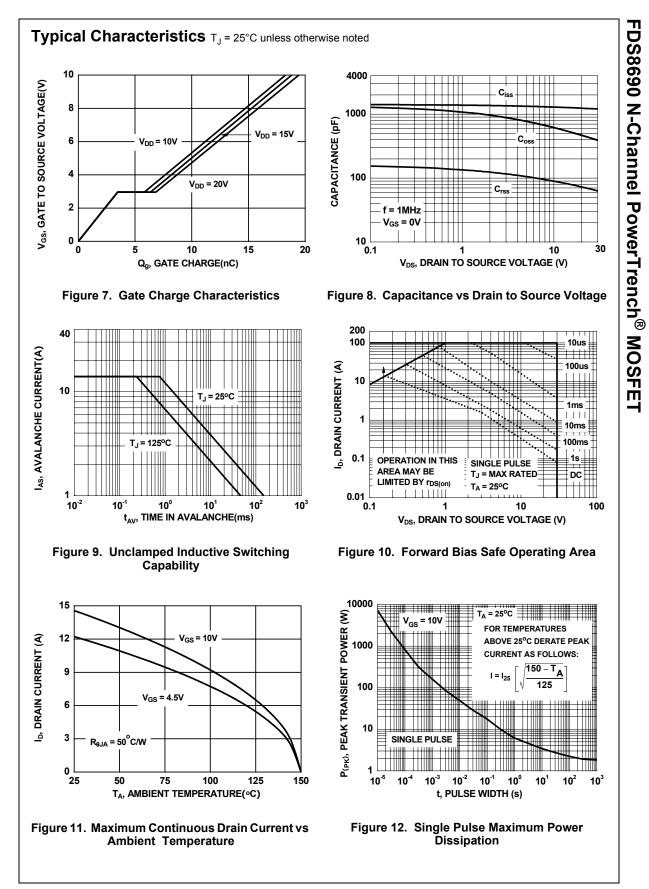
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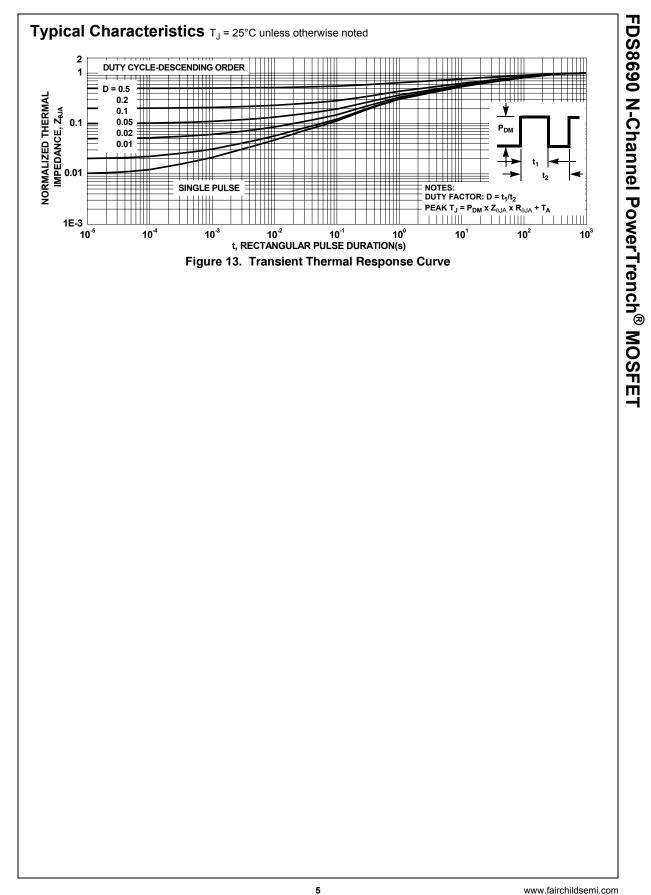
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2. The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied. 3. Starting  $T_J = 25^{\circ}C$ , L = 3mH,  $I_{AS} = 11.8A$ ,  $V_{DD} = 24V$ ,  $V_{GS} = 10V$ .

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